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- (71) Applicant (for all designated States except US): THE REGENTS OF THE UNIVERSITY OF CALIFORNIA [US/US]; 1111 Franklin Street, Oakland, CA 94607-5200 (US).
- (72) Inventors; and
- (75) Inventors/Applicants (for US only): KUMMEL, Andrew, C. [US/US]; 500 West Harbor Drive, Apt. 323, San Diego, CA 92101 (US). YANG, Dengliang [CN/US]; 3951 A Miramar Street, La Jolla, CA 92037 (US). TROGLER, William, C. [US/US]; 2460 Cordero Road, Del Mar, CA 92014 (US). GREDIG, Thomas [CH/US]; 16611 Charles Lane, Huntington Beach, CA 92647 (US).
- (74) Agent: FALLON, Steven, P.; Greer, Burns & Crain, Ltd., 300 S. Wacker Drive Suite 2500, Chicago, IL 60606 (US).

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#### (54) Title: ULTRA-THIN ORGANIC TFT CHEMICAL SENSOR, MAKING THEREOF, AND SENSING METHOD

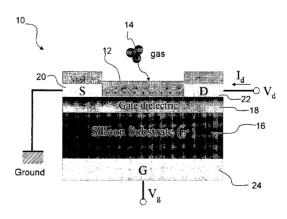


FIG. 1

(57) Abstract: An embodiment of the invention is an organic thin film transistor chemical sensor. The sensor includes a substrate. A gate electrode is isolated from drain and source electrodes by gate dielectric. An organic ultra-thin semiconductor thin film is arranged with respect to the gate, source and drain electrodes to act as a conduction channel in response to appropriate gate, source and drain potentials. The organic ultra-thin film is permeable to a chemical analyte of interest and consists of one or a few atomic or molecular monolayers of material. An example sensor array system includes a plurality of sensors of the invention. In a preferred embodiment, a sensor chip having a plurality of sensors is mounted in a socket, for example by wire bonding. The socket provides thermal and electrical interference isolation for the sensor chip from associated sensing circuitry that is mounted on a common substrate, such as a PCB (printed circuit board). A method of operating an organic thin film transistor chemical sensor exposes the sensor to a suspected analyte. A low duty cycle voltage pulse train is applied to the gate electrode to reduce baseline drift while sensing for a conduction channel change.



International application No. **PCT/US2008/005743** 

#### A. CLASSIFICATION OF SUBJECT MATTER

G01N 27/30(2006.01)i, G01N 27/414(2006.01)i, H01L 29/786(2006.01)i

According to International Patent Classification (IPC) or to both national classification and IPC

#### B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

IPC G01N 27/30, 27/414

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

D/B: eKIPASS

KEY WORD: Organic, Sensor, TFT, Semiconductor

#### C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.	
X	US 2002-0167003 A1 (Ian H. Campbell) 14 NOV. 2002 see page 2, 3, 5; figures 1, 3, 6	1,7	
X / Y	KR 10-2004-0086196 A (Lucent Technologies Inc.) 8 OCT. 2004 see page 1, 4, 5; figures. 1, 2	1,7/15	
Y	US 6575013 B2 (Zhenan Bao et al.) 10 JUN. 2003 see page 2, 3, 7; figures. 1, 8	1, 2, 5, 6	
Y	US 2002-0117693 A1 (Ananth Dodabalapur et al.) 29 AUG. 2002 see page 5, 7; figures 12	1, 2, 5, 6	
X	Thin Solid Films Vol.360: 256-260 (Wenping Hu et al.) Dec. 2000 "The gas sensitivity of a metal-insulator-semiconductor field-effecttransistor based on Langmuir-Blodgett films of a new asymmetrically substituted phthalocyanine" - see page 256-257; figure 2	1	

Further documents are	e listed in the	e continuation	of Box C
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Korean Intellectual Property Office Government Complex-Daejeon, 139 Seonsa-ro, Seogu, Daejeon 302-701, Republic of Korea

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### INTERNATIONAL SEARCH REPORT

International application No.

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Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No
PX/PY	JOURNAL OF APPLIED PHYSICS Vol.102: 034515 (Richard D. Yang et al.) AUG. 2007 "Ultralow drift in organic thin-film transistor chemical sensors by pulsed gating" - see page 34515(1)-34515(4); figure 1	1-5, 9, 10-14 / 15-16
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